

Notice of References Cited	Application/Control No. 09/354,815	Applicant(s)/Patent Under Reexamination TANAKA, TOSHIYUKI	
	Examiner Nhan T. Tran	Art Unit 2615	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,424,772	06-1995	Aoki et al.	348/221.1
	B	US-			
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	D	US-			
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	F	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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